

Notice of References Cited	Application/Control No. 09/943,018		Applicant(s)/Patent Under Reexamination CHEN ET AL.	
	Examiner Yogesh K. Aggarwal		Art Unit 2622	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,538,692	03-2003	Niwa, Mayumi	348/231.1
*	B	US-6,415,107	07-2002	Ogawa, Hidehiro	396/310
*	C	US-5,852,467	12-1998	Ogino, Hiroyuki	348/231.1
*	D	US-5,956,084	09-1999	Moronaga et al.	348/231.9
*	E	US-5,581,311	12-1996	Kuroiwa, Toshihisa	348/231.2
	F	US-			
	G	US-			
	H	US-			
	T	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

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